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BIBDATASHEET

CONFIRMATION NO. 1810

SERIAL NUMBER 09/765,995	FILING DATE 01/19/2001 RULE	CLASS 382	GROUP ART U 2623	4		ATTORNEY DOCKET NO. 002187 USA/C03/PDC/WF/DB	
APPLICANTS							
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** CONTINUING DATA **********************************							
This application is a CON of 09/298,501 04/23/1999 PAT 6,178,257 which is a CON of 08/984,558 12/03/1997 PAT 5,982,921 which is a CON of 07/790,871 11/12/1991 PAT 5,699,447							
FOREIGN APPLICATIONS							
IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 05/01/2001							
Foreign Priority claimed	yes no	STATE OR	SHEETS	тот	ΓAL	INDEPENDENT	
35 USC 119 (a-d) conditions met yes no Met after Allowance Verified and Acknowledged Examiner's Signature Initials		COUNTRY	DRAWING 40	CLA 1		CLAIMS 1	
ADDRESS 32588 APPLIED MATERIALS, INC. 2881 SCOTT BLVD. M/S 2061 SANTA CLARA , CA 95050							
TITLE Optical inspection apparatus for substrate defect detection							
			☐ All Fe	All Fees			
		·	1.16 F	1.16 Fees (Filing)			
FILING FEE FE	ES: Authority has been given in to charge/credit DE for following:	Paper POSIT ACCOUNT	☐ 1.17 F	ees (Pro	Processing Ext. of time)		
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		Credit	☐ Credit				